# Non Magnetic Chips Series

# Low and Medium Voltage Chips Capacitors



# **FEATURES**

- Case sizes: 0505 to 2220
- NPO and X7R dielectrics
- Capacitance range: 10pF to 1µF
- Low ESR/ESL (R12N Series)
- RoHS compliant capacitors

# PHYSICAL CHARACTERISTICS

MLCC capacitors with:

• Copper barrier + pur Tin or Silver Palladium terminations for surface mounting.

# **PACKAGING**

Sizes	Ag/Pd/Pt termination (A code)	Cu termination (C code)
	Parts / reel *	Parts / reel *
R12N (0505)	-	3,000
R14 (0603)	(C code)	3,000 / 4,000
R15 (0805)	Parts / reel *	Parts / reel *
R18 (1206)	3,000 - 4,000	3,000
S41 (1210)	2,000 - 4,000	1,000 - 2,000 - 3,000
S43 (1812)	500 - 1,000	-
S47 (2220)	500 - 1,000	-

<sup>\*</sup> Note: the quantity of parts in a reel depends upon their thicknesses. Please, consult us for more accurate data.

# **ELECTRICAL SPECIFICATIONS**

Description	NPO dielectric	X7R dielectric
Dielectric code	N	Х
CECC class	1B/CG	2R1
EIA class	Class I	Class II
Temperature range	−55°C to +125°C	−55°C to +125°C
Temperature coefficient	(0±30) ppm/°C	NA
Maximum ∆C/°C over temperature range without DC voltage applied	NA	±15%
Rated voltage (U <sub>R</sub> )	50V <sub>DC</sub> to 500V <sub>DC</sub>	$63V_{DC}$ to $500V_{DC}$
Dielectric withstanding voltage	250% rated voltage	250% rated voltage
Insulation resistance (I <sub>R</sub> ) at 25°C under U <sub>R</sub>	$1006\Omega$ or $1,\!000\Omega$ .F whichever is less	100G $\Omega$ or 1,000 $\Omega$ .F whichever is less
Aging	None	≤ 2.5% per decade hour

### **HOW TO ORDER**

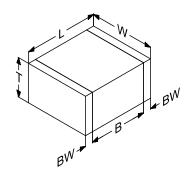
630	S41	N 472		J	С	E
Rated voltage	Rated voltage Exxelia Size Code Dielectric code		Capacitance	Tolerance	Termination	Packaging
500 = 50V 630 = 63V 101 = 100V 151 = 150V 201 = 200V	R12 = 0505 R14 = 0603 R15 = 0805 R18 = 1206 S41 = 1210	N = NPO X = X7R	Capacitance value in code.  1st two digits represent significant figures; last digit specifies the number of zeros to follow.  Examples:  101 = 100pF		C = Pure Tin plated Copper barrier on Pure Silver termination  A = Silver Palladium Platinum termination	- = Bulk  E = tape & reel  (see packaging paragraph for details)
<b>501</b> = 500V	<b>S43</b> = 1812 <b>S47</b> = 2220		472 = 4.7nF 683 = 68nF 564 = 0.56μF 105 = 1μF	$M = \pm 20\%$ $\frac{X7R:}{K = \pm 10\%}$ $M = \pm 20\%$		See page 13



# Low and Medium Voltage Chips Capacitors

# Non Magnetic Chips Series

# DIMENSIONS in inches (mm)



# **STANDARD RATINGS**

	Size	0505		06	603			08	305			12	06	
Exxelia	a size code	R12N NEW		R	14		R15				R18			
Termin	ation code	С	C			A		С	1	4	1	С	ı	A
	L	0.055 ± 0.010 (1.4 ±0.25)	$0.063 \pm 0.012$ $(1.6 \pm 0.3)$		3) (1.6 ± 0.3) 008 0.032 ± 0.008			± 0.012 : 0.3)		± 0.012 0.3)		± 0.012 ± 0.3)	$0.126 \pm 0.012$ $(3.2 \pm 0.3)$	
sı (n	w 0.055 ± 0.010		0.032	± 0.008			0.049	± 0.012 ± 0.3)	0.049 :	± 0.012 ± 0.3)	$0.063 \pm 0.012$ $(1.6 \pm 0.3)$		0.063 ± 0.012 (1.6 ± 0.3)	
Dimensions nches (mm)	B min.	B min. 0.019 0.015 (0.5) (0.4) 0.004 0.005			015 0.4)	0.0	)27 ).7)	0.0 (0	)19 .5)	0.0	.5)		)55 .4)	
in ch	BW min.				0.005 (0.15)			007 1.2)	0.005 (0.13)			011 .3)	0.009 (0.25)	
	T max.	0.055 (1.4)		0.038			0.058     0.058       (1.45)     (1.45)				)71 80)	0.0 (1.	)71 80)	
Die	electric	NPO	NPO	X7R	NPO	X7R	NPO	X7R	NPO	X7R	NPO	X7R	NPO	X7R
Die	Sicotife	N	N	X	N	Х	N	Х	N	X	N	X	N	X
	50V	680pF to 1nF	-	-	-	-	-	-	-	•	-	-	-	-
l <sub>RC</sub> )	63V	-	-	470pF to 15pF	-	4.7nF to 22nF	-	680pF to 22nF	-	10nF to 47nF	ē	1nF to 100nF	-	15nF to 100nF
tage (1	100V	-	47pF to 180pF	-	-	-	47pF to 1nF	-	220pF to 1nF	-	100pF to 2.2nF	-	220pF to 2.2nF	-
Rated voltage (U <sub>RC</sub> )	150V	120pF to 620pF	-	-	-	-	-	-	-	-	-	-	-	-
Rat	200V	-	-	-	-	-	-	-	10pF to 220pF	330pF to 4.7nF	-	-	10pF to 1nF	1nF to 10nF
	500V	-	-	-	-	-	-	-	10pF to 180pF	270pF to 2.2nF	-	-	10pF to 470pF	680pF to 4.7nF

:	Size		12	10			18	12			22	20	
Exxelia	size code		S	41			S4	13			S	47	
Termin	ation code		С		<b>A</b>		С		A		C		A
	,	0.126	± 0.016	0.126	$0.126 \pm 0.016$		0.177 ± 0.02					0.224	± 0.02
	L	(3.2	± 0.4)	$(3.2 \pm 0.4)$			-	(4.5	± 0.5)		-	(5.7	± 0.5)
	w	0.098	± 0.012	0.098	± 0.012			0.126	± 0.016			0.197	± 0.02
SE E	VV	(2.5	± 0.3)	(2.5	± 0.3)		(3.2 ± 0.4)				-	(5 ±	0.5)
nsio (m	B min.	0.0	062	0.0	)55			0.0	186			0.:	114
Dimensions inches (mm)	D IIIIII.		[1.6]		•		(2.2)				-	(2.9)	
三点	BW min.		011		109		0.009				_		009
	511		).3)	(0.					25)				.25)
	T max.		103		199		0.119				-		119
		(2	2.6)	[2	.5)			[:	3)			(3)	
Die	lectric	NPO NPO		NPO	X7R	NP0	X7R	NPO	X7R	NPO	X7R	NPO	X7R
Die	iccurc	N	Х	N	X	N	X	N	X	N	X	N	X
	63V		3.3nF		33nF		150nF		150nF		330nF		330nF
Rated voltage (U <sub>RC</sub> )	034	-	to 100nF	-	to 330nF	-	to 1µF	-	to 1µF	-	to 1µF	-	to 1µF
ا ا	100V	100pF	_	470pF	_	1.8nF	_	1.8nF	_	6.8nF	_	6.8nF	_
tag	1001	to 4.7nF		to 5.6nF		to 5.6nF		to 5.6nF		to 10nF		to 10nF	-
9	200V	2007		100pF	1.5nF	180pF	2.7nF	180pF	2.7nF	680pF	6.8nF	680pF	6.8nF
20				to 2.7nF	to 47nF	to 5.6nF	to 100nF	to 5.6nF	to 100nF	to 10nF	to 220nF	to 10nF	to 220nF
æ	500V	-	-	100pF	1.5nF	180pF	2.7nF	180pF	2.7nF	680pF	6.8nF	680pF	6.8nF
				to 1nF	to 22nF	to 2.2nF	to 47nF	to 2.2nF	to 47nF	to 4.7nF	to 100nF	to 4.7nF	to 100nF

Available capacitance values:

E6, E12 (see page 14). Specific values upon request.

Note: some capacitance values in these tables may not be proposed for small quantities. Please, contact us for confirmation.



# General Information NPO/COG (Class 1)

#### COMPOSITION

NPO capacitors are produced by using a dielectric made of titanium dioxide (Ti  $O_2$ ) modified by magnesium oxide Mg O (white ceramics) or a rare earth oxide, e.g.  $Nd_2O_3$  (other NPO ceramics).

As a consequence, these ceramics are non ferro-electric materials with a low dielectric constant  $\{\mathcal{E}r \leq 110\}$ .

Other additives are used to dope the dielectric constant up to 300. Though derogating from CG class, doped dielectric constant features a linear temperature drift and a matchless stability compared with class 2 ceramics.

The wide range of possible NPO dielectric compositions enables to use the material best suited to the application:

- standard applications,
- high voltage,
- · high temperature,
- microwave,
- · power capacitors.

«Temperature coefficient» compositions are particularly suitable for impedance matching. These ceramics usually enable to achieve temperature coefficients from 0 to  $-1~000~ppm/^{\circ}C$ . For specific requirements, other coefficients can be achieved (e.g.  $-3~300~ppm/^{\circ}C$ ).

#### **STABILITY**

As &r is low, these dielectrics are extremely stable with only minor changes under such stresses as :

- temperature,
- · voltage,
- frequency.

In addition, they are not affected by piezo-electric phenomena and their dielectric absorption coefficients are low and even non measurable for dielectrics with the lowest constants.

### **MECHANICAL PROPERTIES**

Class 1 ceramics are the perfect match for metallic electrodes made of Pd or Ag-Pd alloy and have a high hardness and mechanical toughness making them resistant to thermal shocks (wave soldering for instance) and to thermal cycling after mounting on substrates having an expansion coefficient close to the capacitor one.

Ceramic chips meet CECC 32100 and NF C 93133 standards.

#### **CLIMATIC CATEGORIES**

Climatic categories are identified by three-digit codes as per NF C 20700 standard. Coding method is described in table 6.

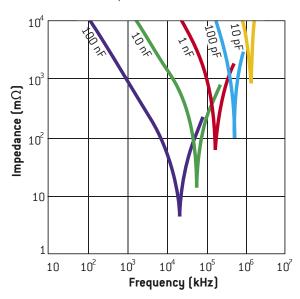
e.g.: -55°C + 125°C / 56 days category is identified by code 434.

# **TEMPERATURE COEFFICIENT**

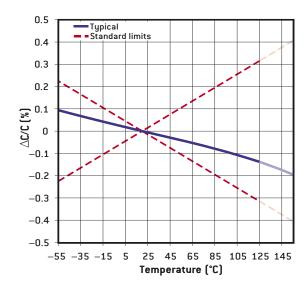
Tempo	erature coefficient k $ heta$ (ppr	m/°C)		
kθ	Tolerances	Code letter		
+ 100	± 30	AG		
0	± 30	CG		
- 33	± 30	HG		
<b>– 75</b>	± 30	LG		
<b>- 150</b>	± 30	PG		
<b>– 220</b>	± 30	RG		
- 330	± 60	SH		
<b>- 470</b>	± 60	TH		
<b>– 750</b>	± 120	UJ		
- 1 000	± 250	ФК		

# General Information NPO/COG (Class 1)

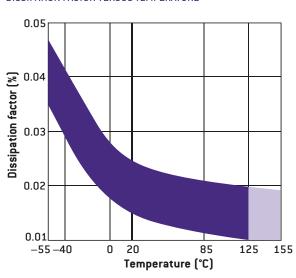
#### IMPEDANCE VERSUS FREQUENCY



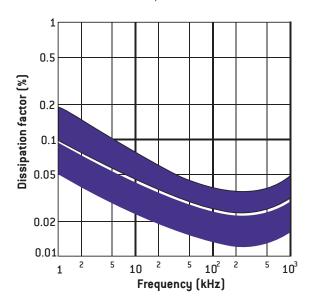
#### CAPACITANCE CHANGE VERSUS TEMPERATURE



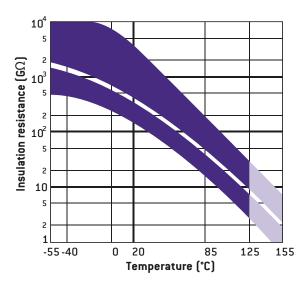
### DISSIPATION FACTOR VERSUS TEMPERATURE



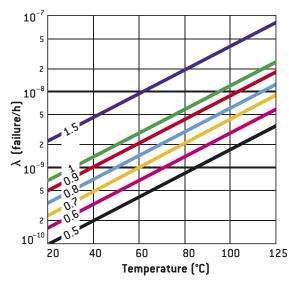
#### DISSIPATION FACTOR VERSUS FREQUENCY



#### IR VERSUS TEMPERATURE



# TYPICAL FAILURE RATE VERSUS TEMPERATURE





# General Information X7R (Class 2)

#### COMPOSITION

Class 2 capacitors are produced by using a dielectric made of barium titanate (Ba Ti  $\theta_3$ ). By nature, the dielectric is a ferroelectric compound with a high dielectric constant usually varying:

- from 1 000 to 5 000 typical of capacitors meeting 2C1 type specifications (BX, X7R).
- from 5 000 to 15 000 typical of capacitors meeting Z5U or Y5V type specifications.

Depending on whether the dielectric contains a flux additive, mainly bismuth or boron, electrodes are made of Ag-Pd alloys with high silver content or high palladium content, even pure palladium in some cases.

## **STABILITY**

As the dielectric is a ferro-electric material, class 2 capacitors present significant variations under such stresses as:

- temperature,
- · voltage,
- frequency.

In addition, the dielectric absorption coefficient can reach a few % and piezo-electric phenomena can affect the dielectric at critical frequencies (full information and specific documents available on request).

#### **MECHANICAL PROPERTIES**

Class 2 dielectrics are hard materials and are sensitive to thermo-mechanical stress. Stress should be limited when mounting and adequate substrates with an adapted expansion coefficient used.

# **BISMUTH OR BISMUTH FREE DIELECTRICS**

Class 2 capacitors are made of ceramics capable to embed a flux element (e.g. bismuth or boron salt). Their eventual use will affect the choice of electrode alloys firing temperature used. Capacitor behavior under such constraints as temperature, voltage, frequency and even reliability, in some applications (further information available on request), is also different.

That is why French and European standard authorities have decided to differentiate bismuth from bismuth free ceramics by measuring tangent  $\delta$  at  $-55^{\circ}$ C. Tangent Tg  $\delta$  ( $-55^{\circ}$ C)  $350.10^{-4}$  in flux free dielectrics.

Flux free dielectrics are identified by suffix «A» after capacitor type (e.g. CNC2A).

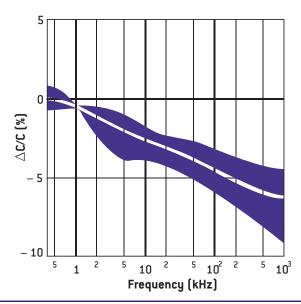
# **CAPACITANCE/TEMPERATURE RELATIONSHIP**

Capacitance variations are defined within a specified temperature range, + 20°C being the reference temperature. This characteristic is expressed by associating the temperature range and capacitance stability.

Stability category	Max. capacitance variation (%) with reference to capacitance at 20°C						
Code letter	Without voltage	At rated DC voltage (U <sub>DC</sub> )					
В	± 10	+ 10– 15					
С	± 20	+ 20 – 30					
D	+ 20 – 30	+ 20 – 40					
E	+ 20 – 55	+ 20 – 65					
R	+ 15 – 15	Not applicable					
Χ	+ 15 – 15	+ 15 – 25					

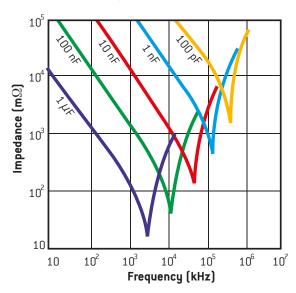
Temperature category							
Code	Temperature range						
1	− 55°C +125°C						
2	– 55°C + 85°C						
4	− 25°C + 85°C						

#### CAPACITANCE CHANGE VERSUS FREQUENCY

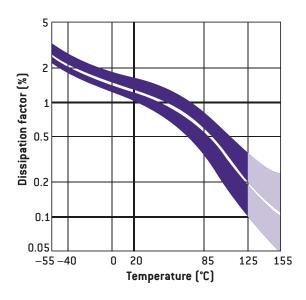


# General Information X7R (Class 2)

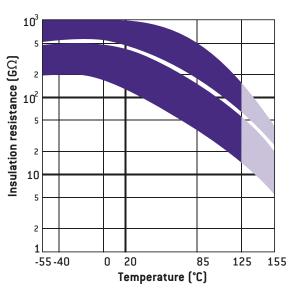
#### IMPEDANCE VERSUS FREQUENCY



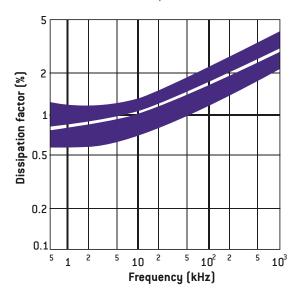
#### DISSIPATION FACTOR VERSUS TEMPERATURE



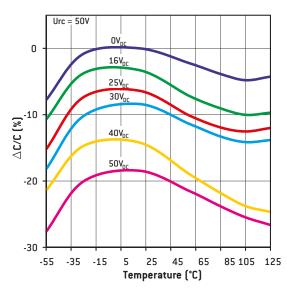
#### IR VERSUS TEMPERATURE



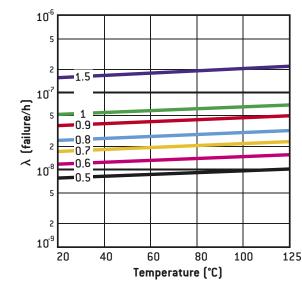
#### DISSIPATION FACTOR VERSUS FREQUENCY



#### CAPACITANCE CHANGE VERSUS TEMPERATURE



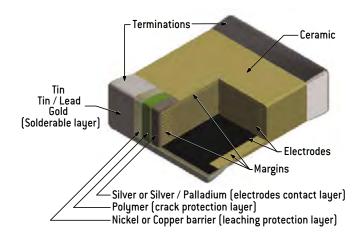
#### TYPICAL FAILURE RATE VERSUS TEMPERATURE





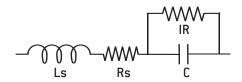
# **Ceramic Capacitors Technology**

### **MLCC STRUCTURE**



# **EQUIVALENT CIRCUIT**

Capacitor is a complex component combining resistive, inductive and capacitive phenomena. A simplified schematic for the equivalent circuit is:



### **DIELECTRIC CHARACTERISTICS**

Insulation Resistance (IR) is the resistance measured under DC voltage across the terminals of the capacitor and consists principally of the parallel resistance shown in the equivalent circuit. As capacitance values and hence the area of dielectric increases, the IR decreases and hence the product (C x IR) is often specified in  $\Omega$ .F or M $\Omega$ . $\mu$ F.

The Equivalent Series Resistance (ESR) is the sum of the resistive terms which generate heating when capacitor is used under AC voltage at a given frequency [f].

**Dissipation factor (DF)** is the ration of the apparent power input will turn to heat in the capacitor:

#### $DF = 2\pi \, f \, C \, ESR$

When a capacitor works under AC voltage, **heat power loss (P)**, expressed in Watt, is equal to:

 $P = 2\pi f C V rms^2 DF$ 

The series inductance (Ls) is due to the currents running through the electrodes. It can distort the operation of the capacitor at high frequency where the impedance (Z) is given as:

$$Z = Rs + j (Ls.\omega - 1/(C.\omega))$$
 with  $\omega = 2\pi f$ 

When frequency rises, the capacitive component of capacitors is gradually canceled up to the resonance frequency, where:

#### Z = Rs and $LsC.\omega^2 = 1$

Above this frequency the capacitor behaves like an inductor.

	P100	NPO	N2200 (C4xx)	вх	2C1	X7R	
Dielectric material	Porcelain	Magnesium titanate or Neodynium baryum titanate	Barium zirconate titanate	Barı	Baryum titanate (BaTi $0_3$ )		
Dielectric constant	15 – 18	20 – 85	450		2,000 – 5,000		
Electrode technology	PME (Precious Metal Electrodes): Ag/Pd						
Capacitance variation between -55°C and +125/°C without DC voltage	(400, 20) //6	(0.20) ///6	(-2,200±500) ppm/°C	±15%	±20%	±15%	
Capacitance variation between -55°C and +125/°C with DC rated voltage	- (100±30)ppm/°C	(0±30)ppm/°C	0 -15%	15% –25%	20% –30%	Not applicable	
Piezo-electric effect		None	None	Yes			
Dielectric absorption		None	Few %	Few %			
Thermal shock sensitive		+	+	++			

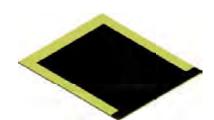
# **Ceramic Capacitors Technology**

# **MANUFACTURING STEPS**



**SLIP CASTING** 

A slurry, a mix of ceramic powder, binder and solvents, is poured onto conveyor belt inside a drying oven, resulting in a dry ceramic sheet.



**ELECTRODE SCREEN PRINTING** 

The electrode ink, made from a metal powder mixed with solvents, is printed onto the ceramic sheets using a screen printing process.

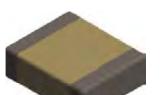
**SINTERING** 



STACKING

The sheets with electrode printed are stacked to create a multilayer structure.

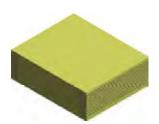
# TERMINATIONS



Each terminal of the capacitor is dipped in the termination ink, mix of metal powder, solvents and glass frit and the parts are fired in an oven.



The parts are sintered in an oven with a precise temperature profile which is very important to the characteristics of the capacitors.



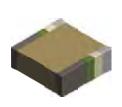
**PRESSING** 

Pressure is applied to the stack to fuse all the separate layers, this created a monolithic structure.

#### **TERMINATIONS PLATING**

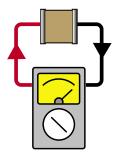








Stacking + leads soldering + encapsulation (see pages 10-11)





### **SMD TERMINATIONS**

						Re	ecommended n	nounting proce	ss		
NON Rohs Compliant	Code	Rohs Compliant	Code	Magnetic	Epoxy bonding	Iron soldering	Wave soldering	Vapor phase soldering	Infrared soldering	Wire bonding	Storage (months)*
Ag	Q	Ag	QW/P	No	•	•	•	•			18
Ag/Pd/Pt	-	Ag/Pd/Pt	W/A	No	•	•	•				24
Ag/Pd/Pt + dipped Sn/Pb 60/40	н	Ag/Pd/Pt + dipped Sn	HW	No		•					24
Ag + Ni + electrolytic Sn/Pb 95/5	С	Ag + Ni + electrolytic Sn	CW/S	Yes		•	•	•	•		18
Ag + Ni + electrolytic Sn/Pb 60/40	D	-	-	Yes		•	•	•	•		18
-	-	Ag + Cu + electrolytic Sn	C**	No		•	•	•	•		18
Ag + Ni + dipped Sn/Pb 60/40	E	-	-	Yes		•	•				24
Ag + Ni + Au	G	Ag + Ni + Au	GW	Yes	•	•	•	•	•	•	36
Ag + Polymer + Ni + Sn/Pb 95/5	YC	Ag + Polymer + Ni + Sn	YCW	Yes		•	•	•	•		18
Ag + Polymer + Ni + Sn/Pb 60/40	YD	-	-	Yes		•	•	•	•		18
Ag + Polymer + Ni + Au	YG	Ag + Polymer + Ni + Au	YGW	Yes	•	•	•	•	•	•	36

Nickel (Ni) or Copper (Cu) barriers amplify thermal shock and are not recommended for chip sizes larger than 3030.

\* Storage must be in a dry environment at a temperature of 20°C with a relative humidity below 50%, or preferably in a package enclosing a desiccant.

## **SMD ENVIRONMENTAL TESTS**

Ceramic chip capacitors for SMD are designed to meet test requirements of CECC 32100 and NF C 93133 standards as specified below in compliance with NF C 20700 and IEC 68 standards:

- Solderability: **NF C 20758,** 260°C, bath 62/36/2.
- Adherence: 5N force.
- Vibration fatigue test: **NF C 20706,** 20 g, 10 Hz to 2,000 Hz, 12 cycles of 20 minutes each.
- Rapid temperature change: NF C 20714, -55°C to + 125°C, 5 cycles.
- Combined climatic test: IEC 68-2-38.
- Damp heat: NF C 20703, 93 %, H.R., 40°C.
- Endurance test: 1,000 hours, 1.5 U<sub>RC</sub>, 125°C.

# STORAGE OF CHIP CAPACITORS

#### TINNED OR NON TINNED CHIP CAPACITORS

Storage must be in a dry environment at a temperature of  $20^{\circ}$ C with a relative humidity below 50 %, or preferably in a packaging enclosing a desiccant.

#### STORAGE IN INDUSTRIAL ENVIRONMENT:

- 2 years for tin dipped chip capacitors,
- 18 months for tin electroplated chip capacitors,
- 2 years for non tinned chip capacitors,
- 3 years for gold plated chip capacitors.

#### STORAGE IN CONTROLLED NEUTRAL NITROGEN ENVIRONMENT:

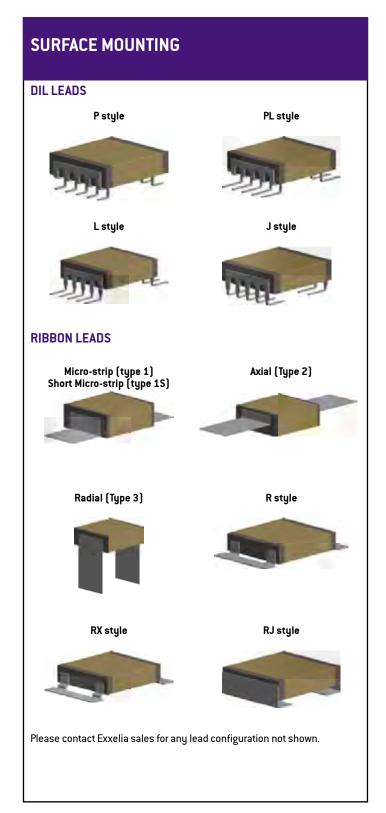
- 4 years for tin dipped or electroplated chip capacitors,
- 4 years for non tinned chip capacitors,
- 5 years for gold plated chip capacitors.

Storage duration should be considered from delivery date and not from batch manufacture date. The tests carried out at final acceptance stage (solderability, susceptibility to solder heat) enable to assess the compatibility to surface mounting of the chips.



<sup>\*\*</sup> Non magnetic chips series only.

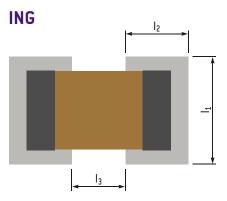
# **LEAD STYLES**







## SOLDERING ADVICES FOR REFLOW SOLDER-



Large chips above size 2225 are not recommended to be mounted on epoxy board due to thermal expansion coefficient mismatch between ceramic capacitor and epoxy. Where larger sizes are required, it is recommended to use components with ribbon or other adapted leads so as to absorb thermo-mechanical strains.

Dimensions			Reflow s	oldering		Wave soldering						
in inches (in mm)			l <sub>2</sub>		l;	l <sub>3</sub>		1	l <sub>2</sub>		l <sub>3</sub>	
0402	0.043	(1.1)	0.035	(0.9)	0.012	(0.3)	0.043	[1.1]	0.047	(1.2)	0.012	(0.3)
0403	0.055	[1.4]	0.035	(0.9)	0.012	(0.3)	0.055	[1.4]	0.047	(1.2)	0.012	(0.3)
0504	0.063	(1.6)	0.051	(1.3)	0.016	(0.4)	0.063	(1.6)	0.063	(1.6)	0.016	(0.4)
0603	0.055	(1.4)	0.059	(1.5)	0.02	(0.5)	0.055	[1.4]	0.071	(1.8)	0.02	(0.5)
0805	0.073	(1.85)	0.065	(1.65)	0.024	(0.6)	0.073	(1.85)	0.077	(1.95)	0.024	(0.6)
0907	0.094	(2.4)	0.065	(1.65)	0.035	(0.9)	0.094	(2.4)	0.077	(1.95)	0.035	(0.9)
1005	0.073	(1.85)	0.067	(1.7)	0.039	(1)	0.073	(1.85)	0.079	(2)	0.039	[1]
1206	0.083	(2.1)	0.067	(1.7)	0.059	(1.5)	0.083	(2.1)	0.079	(2)	0.059	(1.5)
1210	0.118	(3)	0.069	(1.75)	0.059	(1.5)	0.118	(3)	0.081	(2.05)	0.059	(1.5)
1605	0.073	(1.85)	0.071	(1.8)	0.087	(2.2)	0.073	(1.85)	0.083	(2.1)	0.087	(2.2)
1806	0.087	(2.2)	0.073	(1.85)	0.102	(2.6)	0.087	(2.2)	0.085	(2.15)	0.102	(2.6)
1812	0.152	(3.85)	0.073	(1.85)	0.102	(2.6)	0.152	(3.85)	0.085	(2.15)	0.102	(2.6)
1825	0.281	(7.15)	0.073	(1.85)	0.102	(2.6)	0.281	(7.15)	0.085	(2.15)	0.102	(2.6)
2210	0.13	(3.3)	0.079	(2)	0.146	(3.7)	0.13	(3.3)	0.091	(2.3)	0.146	(3.7)
2220	0.228	(5.8)	0.079	(2)	0.146	(3.7)	0.228	(5.8)	0.091	(2.3)	0.146	(3.7)
2225	0.281	(7.15)	0.079	(2)	0.146	(3.7)	0.281	(7.15)	0.091	(2.3)	0.146	(3.7)

#### RECOMMENDED FOOTPRINT FOR SMD CAPACITORS

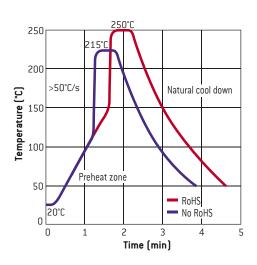
Ceramic is by nature a material which is sensitive both thermally and mechanically. Stresses caused by the physical and thermal properties of the capacitors, substrates and solders are attenuated by the leads.

Wave soldering is unsuitable for sizes larger than 2220 and for the higher ends of capacitance ranges due to possible thermal shock (capacitance values given upon request).

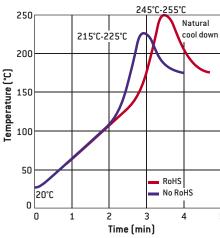
Infrared and vapor phase reflow, are preferred for high reliability applications as inherent thermo-mechanical strains are lower than those inherent to wave soldering.

Whatever the soldering process is, it is highly recommended to apply a thermal cycle, see hereafter our recommended soldering profile:

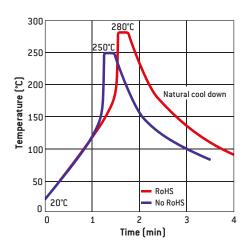
#### RECOMMENDED VAPOR PHASE REFLOW PROFILE



#### RECOMMENDED IR REFLOW PROFIL



#### RECOMMENDED WAVE SOLDERING PROFILE



# **SOLDERING ADVICES FOR IRON SOLDERING**

Attachment with a soldering iron is discouraged due to ceramic brittleness and the process control limitations. In the event that a soldering iron must be used, the following precautions should be observed:

- Use a substrate with chip footprints big enough to allow putting side by side
  one end of the capacitor and the iron tip without any contact between this tip
  and the component,
- place the capacitor on this footprint,

- heat the substrate until the capacitor's temperature reaches 150°C minimum (preheating step, maximum 1°C per second),
- place the hot iron tip (a flat tip is preferred) on the footprint without touching the capacitor. Use a regulated iron with a 30 watts maximum power. The recommended temperature of the iron is 270  $\pm 10^{\circ}$ C. The temperature gap between the capacitor and the iron tip must not exceed 120°C,

- leave the tip on the footprint for a few seconds in order to increase locally the footprint's temperature,
- ullet use a cored wire solder and put it down on the iron tip. In a preferred way use Sn/Pb/Ag 62/36/2 alloy,
- wait until the solder fillet is formed on the capacitor's termination,
- take away iron and wire solder,
- wait a few minutes so that the substrate and capacitor come back down to

the preheating temperature,

- solder the second termination using the same procedure as the first,
- let the soldered component cool down slowly to avoid any thermal shock.

## **PACKAGING**

#### TAPE AND REEL

The films used on the reels correspond to standard IEC 60286-3. Films are delivered on reels in compliance with document IEC 286-3 dated 1991.

Minimum quantity is 250 chips.

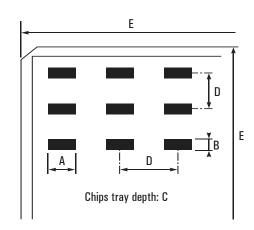
Maximum quantities per reel are as follows:

- Super 8 reel 0 180: 2,500 chips.
- Super 8 reel 0 330: 10,000 chips.
- Super 12 reel 0 180: 1,000 chips.

Reel marking complies with CECC 32100 standard:

- Model.
- Rated capacitance.
- Capacitance tolerance.
- Rated voltage.
- Batch number.

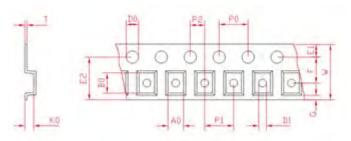
#### TRAY PACKAGES



#### DIMENSIONAL CHARACTERISTICS OF CHIPS TRAY PACKAGES

C:	Nr. of chips/	0-14-4-1	Dimensions in inches (in mm)								
Sizes	package	Oriented chips	A	В	C	D	E				
0402	100	No	0 0.112	(0 3.02)	0.065 (1.65)	0.167 (4.24)	2 (50.8)				
0403	100	No	0 0.112	? (0 3.02)	0.065 (1.65)	0.167 (4.24)	2 (50.8)				
0504	100	Yes	0.059 (1.5)	0.045 (1.14)	0.035 (0.89)	0.167 (4.24)	2 (50.8)				
0603	340	Yes	0.1 (2.54)	0.06 (1.52)	0.045 (1.14)	0.167 (4.24)	2 (50.8)				
0805	100	Yes	0.1 (2.54)	0.06 (1.52)	0.045 (1.14)	0.167 (4.24)	2 (50.8)				
1206	100	No	0.14 (3.56)	0.14 (3.56)	0.06 (1.52)	0.167 (4.24)	2 (50.8)				
1210	100	Yes	0.14 (3.56)	0.14 (3.56)	0.06 (1.52)	0.167 (4.24)	2 (50.8)				
1812	100	No	0.25 (6.35)	0.25 (6.35)	0.13 (3.3)	0.345 (8.76)	4 (101.6)				
1012	25	Yes	0.24 (6.1)	0.265 (6.73)	0.07 (1.78)	0.345 (8.76)	2 (50.8)				
2220	100	Yes	0.25 (6.35)	0.25 (6.35)	0.13 (3.3)	0.345 (8.76)	4 (101.6)				
2220	25	Yes	0.24 (6.1)	0.265 (6.73)	0.07 (1.78)	0.345 (8.76)	2(50.8)				

#### HIGH Q CAPACITORS TAPE AND REEL PACKAGING SPECIFICATIONS



Sizes	Type (1)	W±0.3 inches (mm)	F±0.05 inches (mm)	P1 ±0.1 inches (mm)	T max. inches (mm)	Reel Size inches (mm)	Quantity per Reel
A (0505)	Н	0,315 (8)	0,138 (3.5)	0,157 (4)	0,010 (0,25)	7,087 (180)	3'000
A (0505)	V	0,315 (8)	0,138 (3.5)	0,157 (4)	0,010 (0,25)	7,087 (180)	3'000
S (0603)	Н	0,315 (8)	0,138 (3.5)	0,157 (4)	0,016 (0,4)	7,087 (180)	4'000
F (0805)	Н	0,315 (8)	0,138 (3.5)	0,157 (4)	0,016 (0,4)	7,087 (180)	4'000
B (1111)	Н	0,315 (8)	0,138 (3.5)	0,157 (4)	0,012 (0,3)	7,087 (180)	1'000
B (1111)	V	0,315 (8)	0,138 (3.5)	0,157 (4)	0,010 (0,25)	7,087 (180)	1'000
X (2225)	Н	0,472 (12)	0,138 (5.5)	0,472 (12)	0,018 (0,45)	12,992 (330)	500
E (4040)	Н	0,945 (24)	$0,453^{\pm0,004}$ $(11.5^{\pm0.1})$	0,630 (16)	0,018 (0,45)	12,992 (330)	700
E (4040)	V	1,260 (32)	0,559±0,004 (14.2±0.1)	0,945 (24)	0,022 (0,55)	15 (381)	350

(1): Horizontal (H) or Vertical (V) orientation in cavities.



### **EIA STANDARD CAPACITANCE VALUES**

Following EIA standard, the values and multiples that are indicated in the chart below can be ordered. E48, E96 series and intermediary values are available upon request.

E6 (± 20%)	E12 (± 10%)	E24 (± 5%)
	10	10
10	10	11
10	12	12
	IC	13
	15	15
15		16
15	18	18
	16	20
	22	22
22		24
22	27	27
		30
	33	33
33	33	36
33	20	39
	39	43
	47	47
47		51
47	F.C.	56
	56	62
	60	68
CO	68	75
68	02	82
	82	91

Voltage (V)	Code	Letter code
25	250	Α
40	400	В
50	500	С
63	630	D
100	101	Е
200	201	G
250	251	Н
400	401	K
500	501	L
1,000	102	М
2,000	202	Р
3,000	302	R
4,000	402	S
5,000	502	T
7,500	752	U
10,000	103	W

# **EIA CAPACITANCE CODE**

The capacitance is expressed in three digit codes and in units of pico Farads (pF). The first and second digits are significant figures of the capacitance value and the third digit identifies the multiplier.

For capacitance value < 10pF, R designates a decimal point. See examples below:

FIA d-	Capacitance value			
EIA code	in pF	in nF	in μF	
2R2	2.2	0.0022	0.0000022	
6R8	6.8	0.0068	0.0000068	
220	22	0.022	0.000022	
470	47	0.047	0.000047	
181	180	0.18	0.00018	
221	220	0.22	0.00022	
102	1,000	1	0.001	
272	2,700	2.7	0.0027	
123	12,000	12	0.012	
683	68,000	68	0.068	
124	120,000	120	0.12	
564	560,000	560	0.56	
335	3,300,000	3,300	3.3	
825	8,200,000	8,200	8.2	
156	15,000,000	15,000	15	
686	68,000,000	68,000	68	
107	100,000,000	100,000	100	
227	220,000,000	220,000	220	

# PART MARKING TOLERANCE CODES

Use the following tolerance code chart for part markings:

Tolerance	Letter code
±0.25pF	CU
±0.5pF	DU
±1pF	FU
±1%	F
±2%	G
±5%	J
±10%	K
±20%	М

# PART MARKING VOLTAGE CODES

Use the following voltage code chart for part markings:

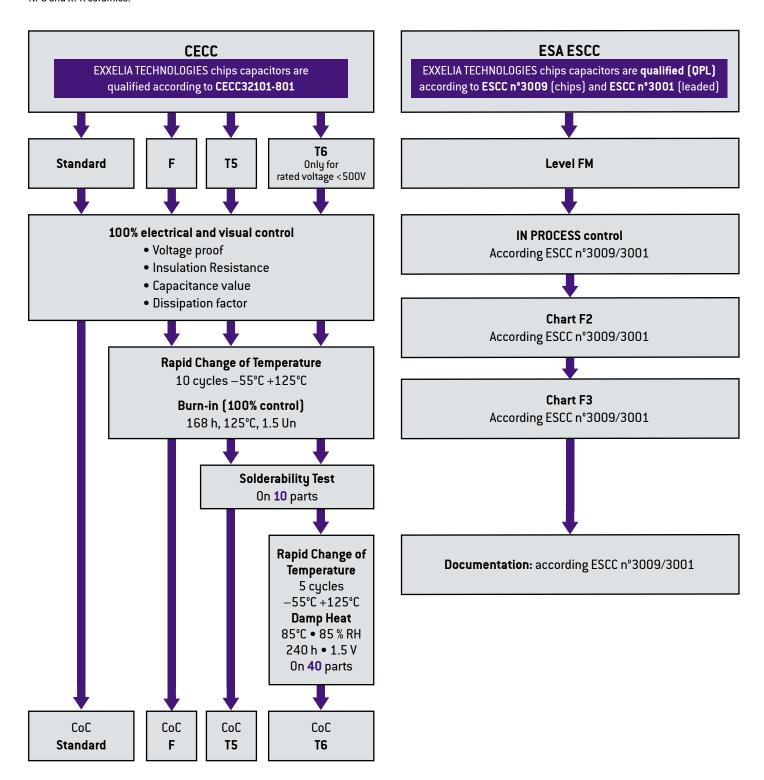


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# **User Guide**

## **RELIABILITY LEVELS**

Exxelia proposes different reliability levels for the ceramic capacitors for both NPO and X7R ceramics.

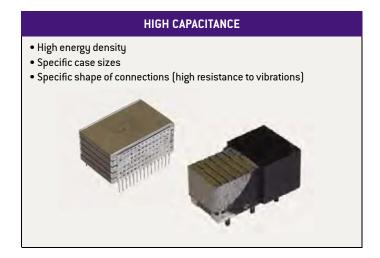


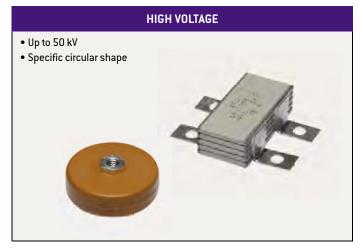


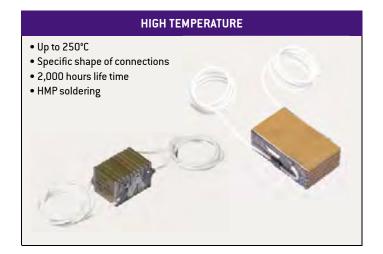
As the world's leading manufacturer of specific passive components, we stand apart through our ability to quickly evaluate the application specific engineering challenges and provide a cost-effective and efficient solutions.

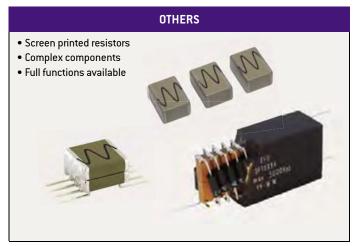
For requirements that cannot be met by catalog products, we offer leading edge solutions in custom configuration: custom geometries, packaging, characteristics, all is possible thanks to our extensive experience and robust development process, while maintaining the highest level of reliability.

Where necessary, special testing is done to verify requirements, such as low dielectric absorption, ultra-high insulation resistance, low dissipation factor, stability under temperature cycling or under specified environmental conditions, etc.









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# **General Information**

# **MATERIALS EXPERT**

For 50 years and as a market leader, EXXELIA's comprehensive knowledge of the materials properties and performances have enabled us to design capacitors in Porcelain, NPO, BX, 2C1, BP, X7R and -2200ppm/°C ceramics.

#### **CUSTOM DESIGNS**

Our catalog products don't meet your application?

Based on the valuable experience accumulated over the design of 2,000+ specific ceramic capacitors, you can trust EXXELIA to define a qualitative custom solution in a time effective manner.

#### NO OBSOLESCENCE

Choosing a standard or custom EXXELIA product means you won't have to worry about obsolescence.

### TYPICAL APPLICATIONS

- Aerospace & Defense: cockpit panels, flight control, radio systems, missile guidance systems...
- Space: military and commercial satellites, launcher...
- Medical: MRI, external defibrillators, implantable devices...
- Telecommunications: base stations...
- Oil and gas: drilling tools, MWD, LWD, wellheads...

## **ISO 9001 AND AS9100C**

Quality is at the core of Exxelia's corporate culture. Each sites has its own certifications.

#### **CERTIFICATIONS**

Capacitors manufactured by EXXELIA comply with American and European standards and meet the requirements of many international standards. For Space qualified parts (ESA QPL), please refer to our catalog «Ceramic capacitors for Space applications».

### **QUALITY & RELIABILITY**

EXXELIA is committed to design and manufacture high quality and reliability products. The test cycles reproducing the most adverse operating conditions over extended periods (up to 10 000 hours) have logged to date well over 5.109 hours/°Component.

Failure rate data can be provided upon request.

#### **CONFLICT MINERALS**

EXXELIA is committed to an approach based on «Conflict Minerals Compliance». This US SEC rule demands complete traceability and a control mechanism for the mineral procurement chain, encouraging importers to buy only «certified» ore.

We have discontinued relations with suppliers that procure from the Democratic Republic of the Congo or an adjoining country.

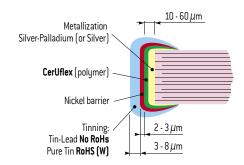
### **ENVIRONMENT**

EXXELIA is committed to applying a robust environmental policy, from product design through to shipment. To control its environmental footprint and reconcile this with the company' functional imperatives, our environmental policy provides for the reduction or elimination of hazardous substances. We also focus on compliance with European Union directives and regulations, notably REACH and RoHS.

#### Rohs Compliancy

#### SMD CAPACITORS

The capacitor terminations are generally protected by a nickel barrier formed by electrolytic deposit. This barrier gives chip capacitors leaching performance far exceeding the requirements of all applicable standards. The nickel barrier guarantees a minimum resistance to soldering heat for a period of 1 minute at 260°C in a tin-lead (60/40) or tin-lead-silver (62/36/2) bath without noticeable alteration to the solderability. It also allows repeated soldering-unsoldering and the longer soldering times required by reflow techniques. However nickel barrier amplifies thermal shock and is not recommended for chip sizes equal or greater than CNC Y (30 30) - (C 282 to C 288 - CNC 80 to CNC 94).



#### LEADED COMPONENTS

As well as for SMD products, leaded capacitors ranges can also be RoHS. These products, which are characterized by the suffix «W» added to the commercial type, are naturally compatible with the soldering alloys used in RoHS mounting technology. The connections coating is generally an alloy SnAg (with a maximum of 4% Ag). However, on a few products that EXXELIA will precise on request, the coating is pure silver.

